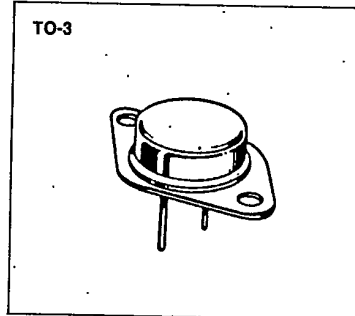
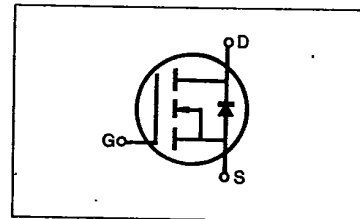


IRF320/321/322/323**N-CHANNEL
POWER MOSFETS****FEATURES**

- Low $R_{DS(on)}$
- Improved inductive ruggedness
- Fast switching times
- Rugged polysilicon gate cell structure
- Low input capacitance
- Extended safe operating area
- Improved high temperature reliability
- TO-3 package (Standard)

**PRODUCT SUMMARY**

Part Number	V_{DS}	$R_{DS(on)}$	I_D
IRF320	400V	1.8 Ω	3.0A
IRF321	350V	1.8 Ω	3.0A
IRF322	400V	2.5 Ω	2.5A
IRF323	350V	2.5 Ω	2.5A

**MAXIMUM RATINGS**

Characteristic	Symbol	IRF320	IRF321	IRF322	IRF323	Unit
Drain-Source Voltage (1)	V_{DSS}	400	350	400	350	Vdc
Drain-Gate Voltage ($R_{GS}=1.0M\Omega$) (1)	V_{DGR}	400	350	400	350	Vdc
Gate-Source Voltage	V_{GS}	± 20				Vdc
Continuous Drain Current $T_C=25^\circ C$	I_D	3.0	3.0	2.5	2.5	Adc
Continuous Drain Current $T_C=100^\circ C$	I_D	2.0	2.0	1.5	1.5	Adc
Drain Current—Pulsed (3)	I_{DM}	12	12	10	10	Adc
Gate Current—Pulsed	I_{GM}	± 1.5				Adc
Total Power Dissipation @ $T_C=25^\circ C$	P_D	40				Watts
Derate above $25^\circ C$		0.32				$W/^\circ C$
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-55 to 150				$^\circ C$
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	T_L	300				$^\circ C$

Notes: (1) $T_J=25^\circ C$ to $150^\circ C$

(2) Pulse test: Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

(3) Repetitive rating: Pulse width limited by max. junction temperature

IRF320/321/322/323**N-CHANNEL
POWER MOSFETS****ELECTRICAL CHARACTERISTICS** ($T_C=25^\circ\text{C}$ unless otherwise specified)

Characteristic	Symbol	Type	Min	Typ	Max	Units	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	IRF320 IRF322	400	—	—	V	$V_{GS}=0V$
		IRF321 IRF323	350	—	—	V	$I_D=250\mu A$
Gate Threshold Voltage	$V_{GS(th)}$	ALL	2.0	—	4.0	V	$V_{DS}=V_{GS}$, $I_D=250\mu A$
Gate-Source Leakage Forward	I_{GSS}	ALL	—	—	100	nA	$V_{GS}=20V$
Gate-Source Leakage Reverse	I_{GSS}	ALL	—	—	-100	nA	$V_{GS}=-20V$
Zero Gate Voltage Drain Current	I_{DSS}	ALL	—	—	250	μA	$V_{DS}=\text{Max. Rating}$, $V_{GS}=0V$
			—	—	1000	μA	$V_{DS}=\text{Max. Rating} \times 0.8$, $V_{GS}=0V$, $T_C=125^\circ\text{C}$
On-State Drain-Source Current (2)	$I_{D(on)}$	IRF320 IRF321	3.0	—	—	A	$V_{DS}>I_{D(on)} \times R_{DS(on)}$ max., $V_{GS}=10V$
		IRF322 IRF323	2.5	—	—	A	
Static Drain-Source On-State Resistance (2)	$R_{DS(on)}$	IRF320 IRF321	—	1.4	1.8	Ω	$V_{GS}=10V$, $I_D=1.5A$
		IRF322 IRF323	—	1.7	2.5	Ω	
Forward Transconductance (2)	g_{fs}	ALL	1.0	2.2	—	Ω	$V_{DS}>I_{D(on)} \times R_{DS(on)}$ max., $I_D=1.5A$
Input Capacitance	C_{iss}	ALL	—	460	600	pF	$V_{GS}=0V$, $V_{DS}=25V$, $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	ALL	—	90	200	pF	
Reverse Transfer Capacitance	C_{rss}	ALL	—	30	40	pF	
Turn-On Delay Time	$t_{d(on)}$	ALL	—	—	40	ns	$V_{DD}=0.5BV_{DSS}$, $I_D=1.5A$, $Z_\theta=50\Omega$ (MOSFET switching times are essentially independent of operating temperature.)
Rise Time	t_r	ALL	—	—	50	ns	
Turn-Off Delay Time	$t_{d(off)}$	ALL	—	—	100	ns	
Fall Time	t_f	ALL	—	—	50	ns	
Total Gate Charge (Gate-Source Plus Gate-Drain)	Q_g	ALL	—	12.5	15	nC	$V_{GS}=10V$, $I_D=4.0A$, $V_{DS}=0.8$ Max. Rating (Gate charge is essentially independent of operating temperature.)
Gate-Source Charge	Q_{gs}	ALL	—	2.8	—	nC	
Gate-Drain ("Miller") Charge	Q_{gd}	ALL	—	9.7	—	nC	

THERMAL RESISTANCE

Junction-to-Case	R_{thJC}	ALL	—	—	3.12	K/W	
Case-to-Sink	R_{thCS}	ALL	—	0.1	—	K/W	Mounting surface flat, smooth, and greased
Junction-to-Ambient	R_{thJA}	ALL	—	—	30	K/W	Free Air Operation

Notes: (1) $T_J=25^\circ\text{C}$ to 150°C

(2) Pulse test: Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

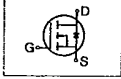
(3) Repetitive rating: Pulse width limited by max. junction temperature



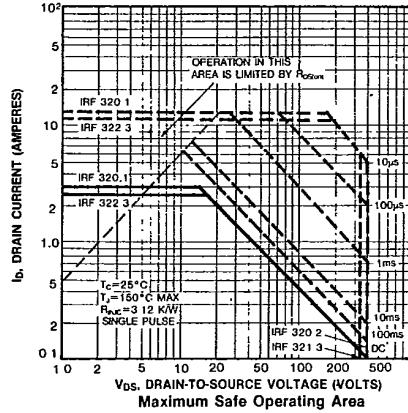
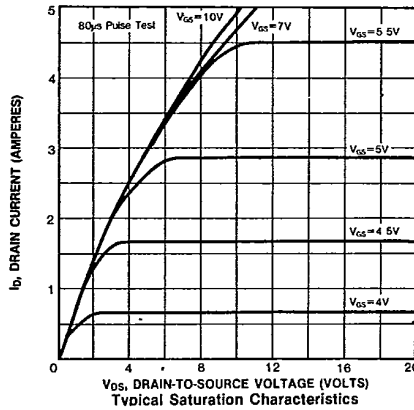
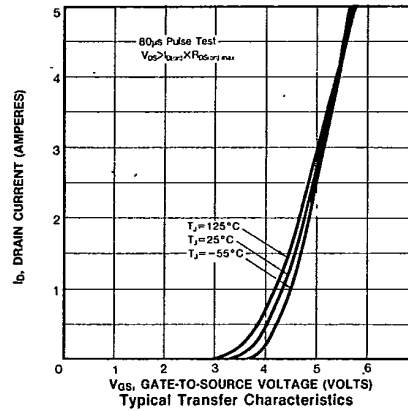
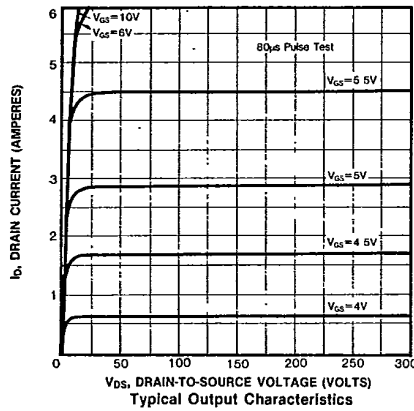
IRF320/321/322/323

**N-CHANNEL
POWER MOSFETS**

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

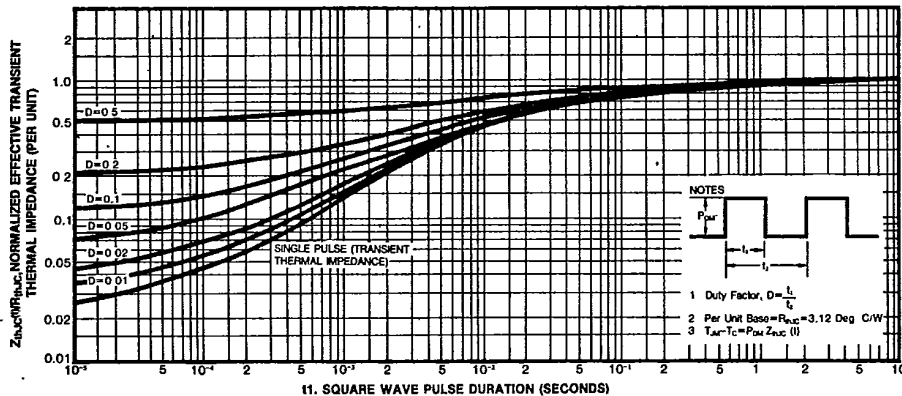
Characteristic	Symbol	Type	Min	Typ	Max	Units	Test Conditions
Continuous Source Current (Body Diode)	I_S	IRF320	—	—	3.0	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier 
		IRF321	—	—	3.0	A	
		IRF322 IRF323	—	—	2.5	A	
Pulse Source Current (Body Diode) (3)	I_{SM}	IRF320	—	—	12	A	
		IRF321	—	—	12	A	
		IRF322 IRF323	—	—	10	A	
Diode Forward Voltage (2)	V_{SD}	IRF320	—	—	1.6	V	$T_C=25^\circ\text{C}$, $I_S=3.0\text{A}$, $V_{GS}=0\text{V}$
		IRF321	—	—	1.6	V	$T_C=25^\circ\text{C}$, $I_S=3.0\text{A}$, $V_{GS}=0\text{V}$
		IRF322 IRF323	—	—	1.5	V	$T_C=25^\circ\text{C}$, $I_S=2.5\text{A}$, $V_{GS}=0\text{V}$
Reverse Recovery Time	t_{rr}	ALL	—	450	—	ns	$T_J=150^\circ\text{C}$, $I_F=3.0\text{A}$, $dI_F/dt=100\text{A}/\mu\text{s}$

Notes: (1) $T_J=25^\circ\text{C}$ to 150°C (2) Pulse test: Pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
 (3) Repetitive rating: Pulse width limited by max. junction temperature

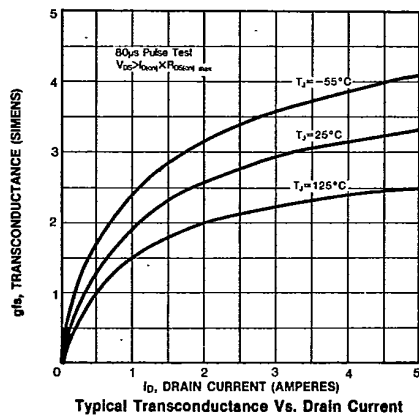


IRF320/321/322/323

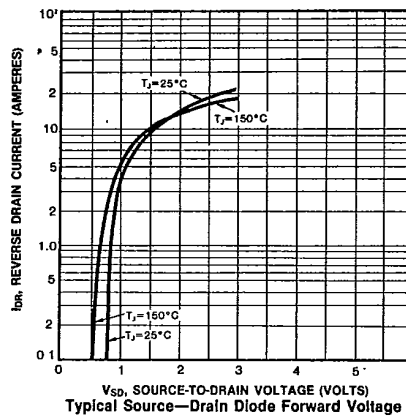
N-CHANNEL
POWER MOSFETS



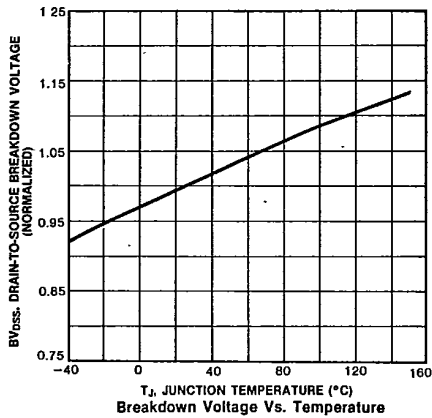
11. SQUARE WAVE PULSE DURATION (SECONDS)
Maximum Effective Transient Thermal Impedance Junction-to-Case Vs. Pulse Duration



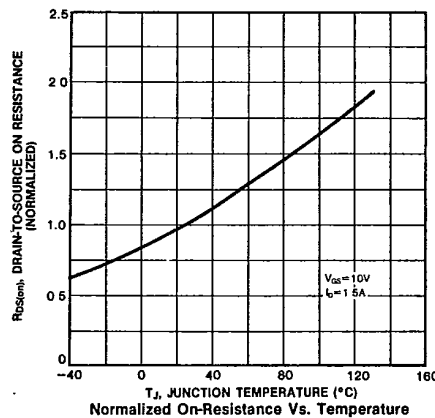
Typical Transconductance Vs. Drain Current



Typical Source-Drain Diode Forward Voltage



Breakdown Voltage Vs. Temperature



Normalized On-Resistance Vs. Temperature



IRF320/321/322/323

N-CHANNEL
POWER MOSFETS

